Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/010,826	SCHMIT ET AL.	
Examiner	Art Unit	
Sunray Chang	2121	

SEARCHED				
Class	Subclass	Date	Examiner	
700	29, 28,44	5/28/2005	sc	
702	122, 123	6/13/2005	sc	

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
700	28, 29,44	5/28/2005	sc		
702	122, 123	6/13/2005	sc		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (USPAT, US_PGPUB, JPO, EPO, DERWENT, IBM_TDB)	6/13/2005	sc		
consult with Hal Wachsman	6/13/2005	sc		